## Applicant(s)/Patent Under Application/Control No. Reexamination 10/801,040 HETHUIN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2663 Richard Chang **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY 04-2002 370/337 US-6,366,569 Ritter, Gerhard A 04-2003 Suzuki, Mitsuhiro 370/347 В US-2003/0063597 US-2004/0008617 01-2004 370/208 С Dabak et al. US-D US-Ε F US-US-G Н US-USı US-J US-Κ US-L М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) u W

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Notice of References Cited

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